FORM PTO 1449 (ATTY DOCKET NO. 03500.015726.	APPLICATION	NO 09/941,59	15
U.S. DEPARTMENT OF COMMERCE JC13			APPLICANT			
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	6,400,091 B1	06/02	Deguchi et al.	315	169.1	03/14/0
	6,472,814 B1	10/02	Yamanobe et al.	313	495	11/13/9
	5,872,422	02/99	Xu et al.	313	311	
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	2002/0009637A1	01/02	Murakami et al.	429	213	02/05/0
	5,773,921	06/30/98	Keesman et al.	313	309	<u> </u>
	5,935,639	8/10/99	Sullivan et al.	427	78	
	4,956,578	9/11/90	Shimizu et al.	315	3	
	5,185,554	2/9/93	Nomura et al.	313	495	
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FORM PTO 144		MATOOT	ATTY DOCKET NO. 03500.015726.	APPLICATI	ON NO. 09/941,	595
LIST	U.S. DEPARTMENT OF CO PATENT AND TRADEMARK OF REFERENCES CITED BY	APPLICANT(S)	APPLICANT Takeo Tsul	kamoto		
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	4,816,289	03/89	Komatsu et al	423	447.3	
	5,443,859	08/95	Nagata	427	122	
	5,618,875	04/97	Baker et al.	524	495	
	5,690,997	11/97	Grow	427	249.1	
	6,129,602	10/00	Yamanobe	445	24	
	6,228,904	05/01	Yadav et al.	523	210	
	6,333,016	12/01	Resasco et al.	423	447.3	09/03/99
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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO	1449 (<i>modified</i>)		ATTY DOCKET NO.	APPLICATI	ION NO.	
	U.S. DEPARTMENT OF COM	MERCE	03500.015726.	<u> </u>	09/941,5	<u> 595</u>
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V	2003/0048056 A1	3/03	Kitamura et al.	313	311	
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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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		APPLICANT Takeo Ts	ukamoto			
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	0 290 026 B1	02/93	EPO	H01J	3/02	English
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	0 716 439 A1	06/12/96	EPO	H01J	3/02	English
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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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m	2-112125	04/24/90	JAPAN	H01J	1/30	Abst. & Counterpart U.S. Patent 4,956,578
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	5-211029	08/20/93	JAPAN	H01J	1/30	No
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	04-212236	08/03/92	Japan	H01J	1/30	Counterpart U.S. Patents 5,192,240, 5,214,348 & EP 0 443 865
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V	05-274997	10/22/93	Japan	H01J	1/30	Abst. & Counterpart U.S. Patent 5,612,587
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	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
ms	11-232997	08/27/99	Japan	но1Ј	1/30	Counterpart U.S. Patent 6,313,572 & EP 0 936 650
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FORM PTO 14	PER	ATTY DOCKET NO. 03500.015726.	APPLICATION NO. 09/941,595				
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LIST	OF REFERENCES CITED BY APPLICANT(S)	APPLICANT Takeo Tsukamoto		
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